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Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/792,062	WANG ET AL.	
Examiner	Art Unit	
Pierre-Louis Desir	2681	

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Class	Subclass	Date	Examiner
455	456.6	10/15/2005	PD
455	456.1	10/15/2005	PD
455	411	10/15/2005	PD
380	285	10/15/2005	PD
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INT	INTERFERENCE SEARCHED		
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	DATE	EXMR
EAST	10/15/2005	PD

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